3.3 V ECL 1:2 Fanout Buffer

FEATURES

- 1:2 ECL Fanout Buffer
- Operating Range
  - PECL V_{CC} = 3.0 V to 3.8 V With V_{EE} = 0 V
  - NECL: V_{CC} = 0 V with V_{EE} = –3.0 to –3.8V
- 5 ps Skew Between Outputs
- Support for Clock Frequencies > 2.0 GHz
- 265 ps Typical Propagation Delay
- Deterministic Output Value for Open Input Conditions or When Inputs = V_{EE}
- Built-in Temperature Compensation
- Drop in Compatible to MC10LVEL11, MC100LVEL11
- Built-In Input Pull Down Resistors

APPLICATIONS

- Data and Clock Transmission Over Backplane
- Signaling Level Conversion

DESCRIPTION

The SN65LVEL11 is a fully differential 1:2 ECL fanout buffer. The device includes circuitry to maintain a known logic level when inputs are in open condition. The SN65LVEL11 is functionally equivalent to SN65EL11 with improved performance. The SN65LVEL11 is housed in an industry standard SOIC-8 package and is also available in the TSSOP-8 package option.

PINOUT ASSIGNMENT

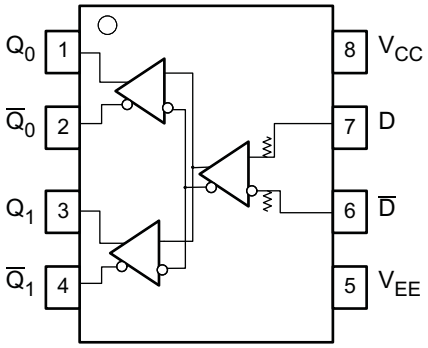


Table 1. Pin Description

PIN	FUNCTION
D, $\overline{D}$	PECL/ECL data inputs
Q_0, $\overline{Q}_0$, Q_1, $\overline{Q}_1$	PECL/ECL outputs
V_{CC}	Positive supply
V_{EE}	Negative supply

ORDERING INFORMATION(1)

PART NUMBER	PART MARKING	PACKAGE	LEAD FINISH
SN65LVEL11D	SN65LVEL11	SOIC	NiPdAu
SN65LVEL11DGK	SN65LVEL11	SOIC-TSSOP	NiPdAu

(1) Leaded device options not initially available. Contact TI sales representative for further details.

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ABSOLUTE MAXIMUM RATINGS(1)

PARAMETER	CONDITION	VALUE	UNIT
Absolute PECL mode supply voltage, V_{CC}	V_{EE} = 0 V	6	V
Absolute NECL mode power supply, V_{EE}	V_{CC} = 0 V	–6	V
PECL mode input voltage	V_{EE} = 0 V; $V_I \le$ VCC	6	V
NECL mode input voltage	V_{CC} = 0 V; $V_I \ge V_{EE}$	–6	V
Output current	Continuous	50	mA
	Surge	100	
Operating temperature range		–40 to 85	°C
Storage temperature range		–65 to 150	°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

POWER DISSIPATION RATINGS

PACKAGE	CIRCUIT BOARD MODEL	POWER RATING T_A < 25°C (mW)	THERMAL RESISTANCE, JUNCTION TO AMBIENT NO AIRFLOW	DERATING FACTOR T_A > 25°C (mW/°C)	POWER RATING T_A = 85°C (mW)
SOIC	Low-K	719	139	7	288
	High-K	840	119	8	336
SOIC-TSSOP	Low-K	469	213	5	188
	High-K	527	189	5	211

THERMAL CHARACTERISTICS

PARAMETER		PACKAGE	VALUE	UNIT
θ_{JB}	Junction-to Board Thermal Resistance	SOIC	79	°C/W
		SOIC-TSSOP	120	
θ_{JC}	Junction-to Case Thermal Resistance	SOIC	98	°C/W
		SOIC-TSSOP	74	

KEY ATTRIBUTES

CHARACTERISTICS	VALUE
Internal input pull down resistor	75 kΩ
Moisture sensitivity level	Level 1
Flammability rating (Oxygen Index: 28 to 34)	UL 94 V-0 at 0.125 in
ESD-HBM	4 kV
ESD-machine model	200 V
ESD-charge device model	2 kV
Meets or exceeds JEDEC Spec EIA/JESD78 latchup test	

LVPECL DC CHARACTERISTICS[1] (V_{CC} = 3.3 V, V_{EE} = 0.0 V[2])

CHARACTERISTICS		–40°C			25°C			85°C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
I_{CC}	Power Supply Current		20	25		20	25		21	25	mA
V_{OH}	Output HIGH Voltage [3]	2215		2420	2215	2286	2420	2215		2420	mV
V_{OL}	Output LOW Voltage[3]	1470		1680	1470	1584	1680	1470		1680	mV
V_{IH}	Input High Voltage (Single-Ended)	2135		2420	2135		2420	2135		2420	mV
V_{IL}	Input LOW Voltage (Single-Ended)	1490		1825	1490		1825	1490		1825	mV
V_{IHCMR}	Input HIGH voltage common mode range (Differential) [4]										V
	V_{pp} < 500 mV	1.2		3.1	1.1		3.1	1.1		3.1	
	V_{pp} > 500 mV	1.4		3.1	1.3		3.1	1.3		3.1	
I_{IH}	Input HIGH Current			150			150			150	µA
I_{IL}	Input LOW current										
	D	0.5			0.5			0.5			µA
	$\overline{D}$	–600			–600			–600			

(1) Device will meet the specifications after thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
(2) Input and output parameters vary 1:1 with V_{CC}. V_{EE} can vary ±0.3 V
(3) Outputs are terminated through a 50 Ω resistor to V_{CC} – 2.0 V.
(4) V_{IHCMR} min varies 1:1 with V_{EE}, V_{IHCMR} max varies 1:1 with V_{CC}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between V_{PP} min and 1 V.

LVPNECL DC CHARACTERISTICS[1] (V_{EE} = –3.3 V; V_{CC} = 0.0 V;) [2]

CHARACTERISTICS		–40°C			25°C			85°C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
I_{EE}	Power supply current		20	25		20	25		21	25	mA
V_{OH}	Output HIGH voltage [3]	–1085		–880	–1085	–1013	–880	–1085		–880	mV
V_{OL}	Output LOW voltage[3]	–1830		–1620	–1830	–1722	–1620	–1830		–1620	mV
V_{IH}	Input high voltage (Single-Ended)	–1165		–880	–1165		–880	–1165		–880	mV
V_{IL}	Input LOW voltage (Single-Ended)	–1810		–1475	–1810		–1475	–1810		–1475	mV
V_{IHCMR}	Input HIGH voltage common mode range (Differential) [4]										V
	V_{pp} < 500 mV	–2.1		–0.2	–2.2		–0.2	–2.2		–0.2	
	V_{pp} > 500 mV	–1.9		–0.2	–2.0		–0.2	–2.0		–0.2	
I_{IH}	Input HIGH current			150			150			150	µA
I_{IL}	Input LOW current										
	D	0.5			0.5			0.5			µA
	$\overline{D}$	–600			–600			–600			

(1) Device will meet the specifications after thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
(2) Input and output parameters vary 1:1 with V_{CC}. V_{EE} can vary ±0.3 V.
(3) Outputs are terminated through a 50 Ω resistor to V_{CC} – 2.0 V.
(4) VIHCMR min varies 1:1 with V_{EE}, V_{IHCMR} max varies 1:1 with V_{CC}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between VPP min and 1 V.

AC CHARACTERISTICS [1](V_{CC} = 3.3 V; V_{EE} = 0.0 V or V_{CC} = 0.0 V; V_{EE} = –3.3 V)[2]

CHARACTERISTIC		–40°C			25°C			85°C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
f_{MAX}	Max switching frequency[3] See Figure 6		2.9			2.7			2.4		GHz
t_{PLH}/t_{PHL}	Propagation delay to output	235		350	235		350	235		350	ps
t_{SKEW}	Within device skew[4]		10	18		10	18		10	18	ps
	Device to device skew[5]		10	25		10	25		10	25	ps
	Duty cycle skew[6]		5	15		5	15		5	15	ps
t_{JITTER}	Random clock jitter (RMS)		0.2			0.2			0.2		ps
V_{PP}	Input swing[7]	200		1000	200		1000	200		1000	mV
t_r/t_f	Output rise/fall times Q (20%–80%)	150		300	150		300	150		300	ps

(1) Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
(2) V_{EE} can vary ±0.3 V
(3) Maximum switching frequency measured at output amplitude of 300 mVpp.
(4) Within-device skew is defined as identical transitions on similar paths through a device.
(5) Device-Device Skew is defined as identical transitions at identical Vcc levels.
(6) Duty cycle skew is the difference between a t_{PLH} and t_{PHL} propagation delay through a device.
(7) $V_{PP(min)}$ is the minimum input swing for which AC parameters are assured.

Typical Termination for Output Driver

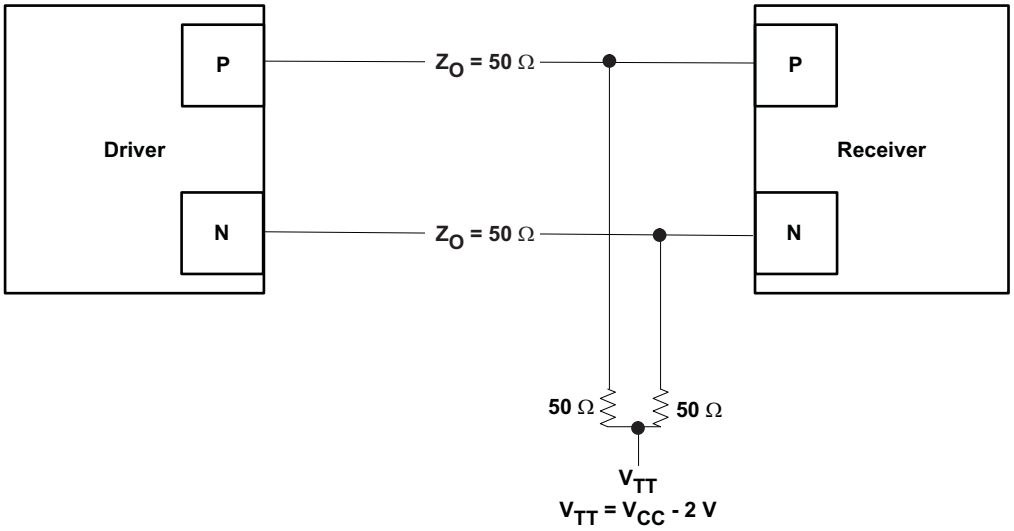


Figure 1. Termination for Output Driver

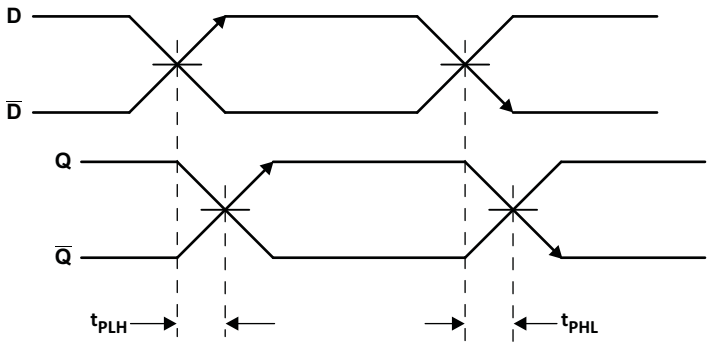


Figure 2. Propagation Delay

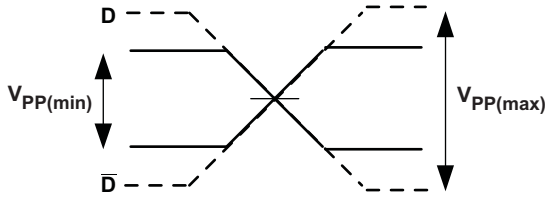


Figure 3. Input Voltage Swing

Figure 4. Output Rise and Fall Times

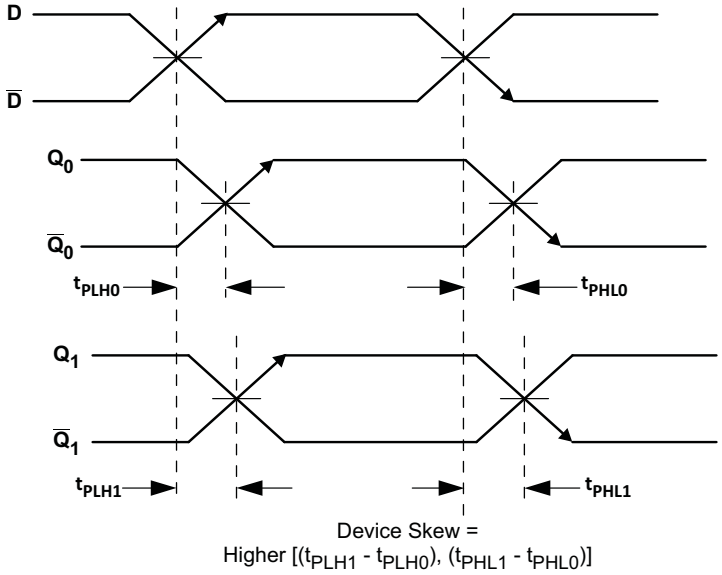


Figure 5. Device Skew

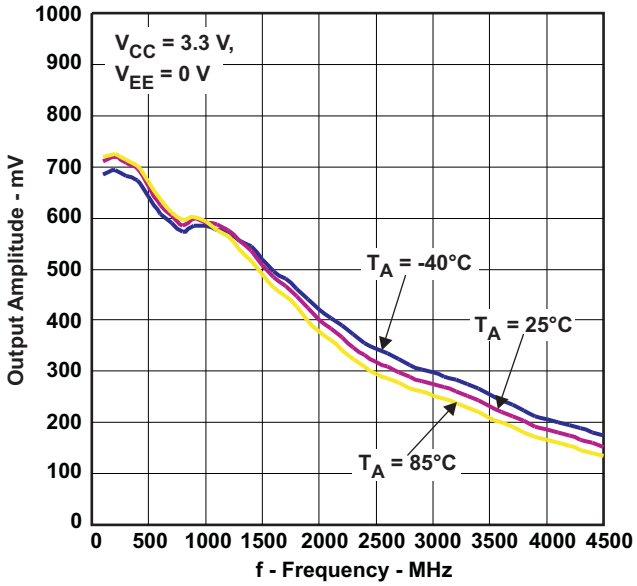


Figure 6. Output Amplitude vs Frequency

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN65LVEL11D	Active	Production	SOIC (D) | 8	75 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEL11
SN65LVEL11D.B	Active	Production	SOIC (D) | 8	75 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEL11
SN65LVEL11DGK	Active	Production	VSSOP (DGK) | 8	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SINI
SN65LVEL11DGK.B	Active	Production	VSSOP (DGK) | 8	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SINI
SN65LVEL11DGKR	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	Call TI | Nipdau	Level-1-260C-UNLIM	-40 to 85	SINI
SN65LVEL11DGKR.B	Active	Production	VSSOP (DGK) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SINI
SN65LVEL11DR	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEL11
SN65LVEL11DR.B	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVEL11

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

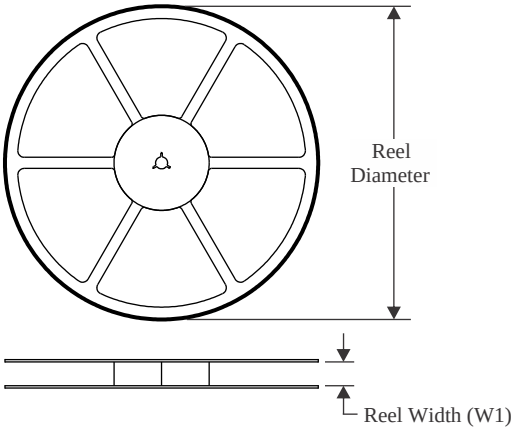
(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

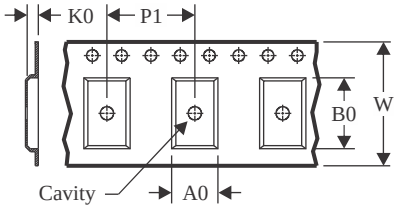
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

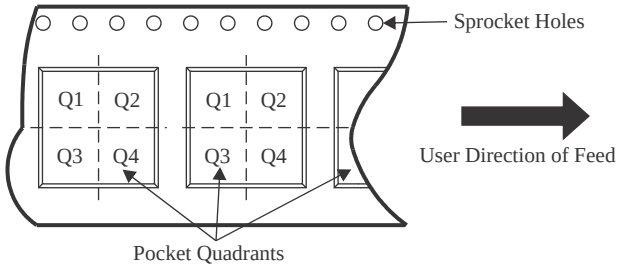


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

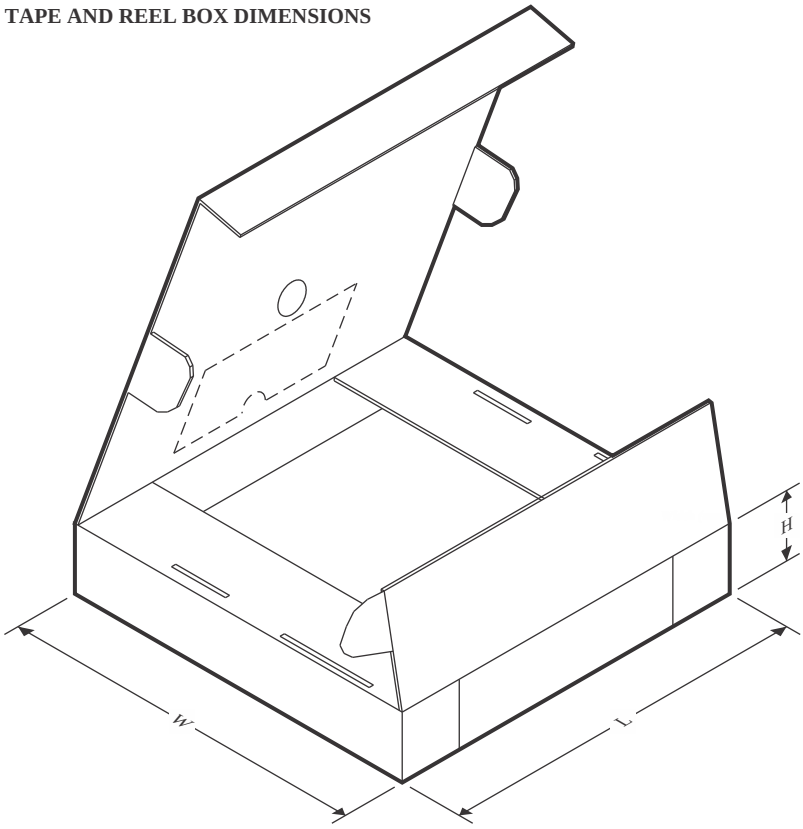
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LVEL11DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

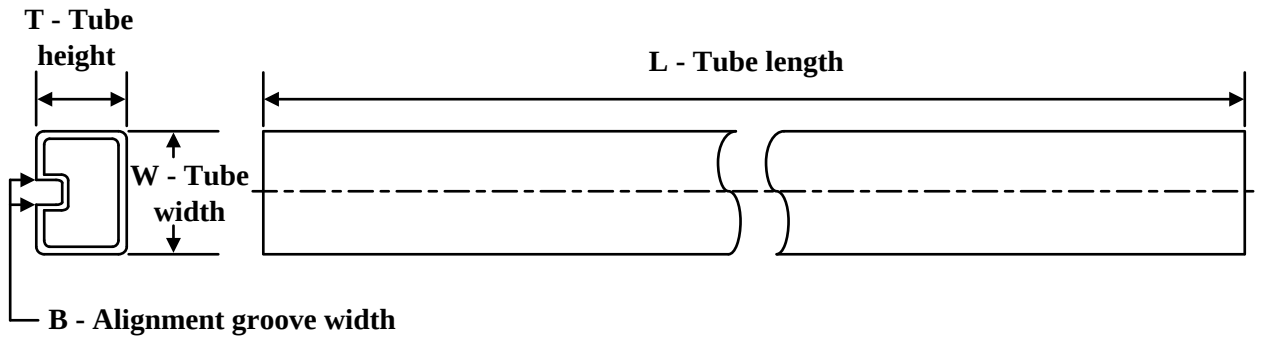
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVEL11DR	SOIC	D	8	2500	353.0	353.0	32.0

TUBE



*All dimensions are nominal

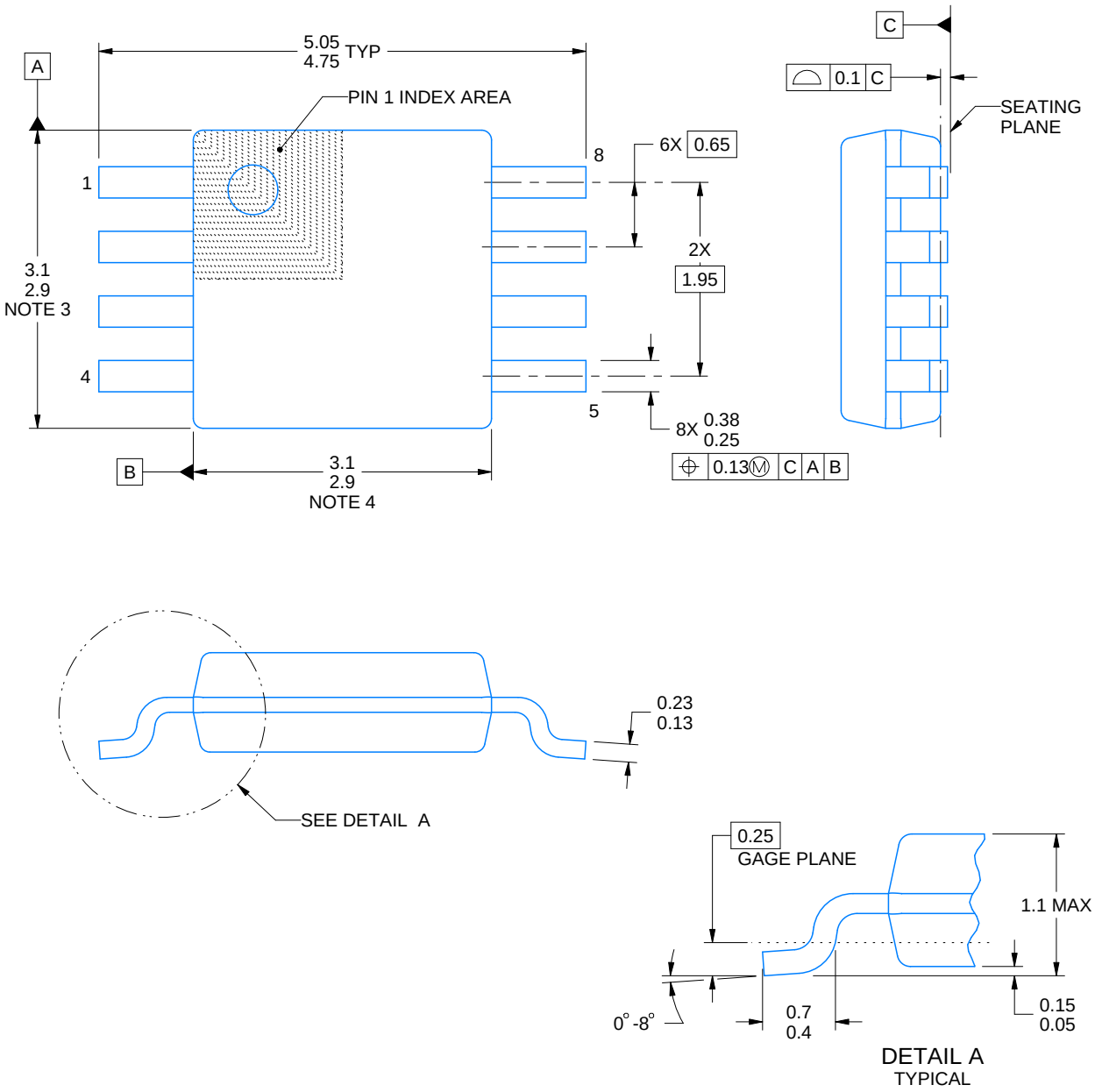
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN65LVEL11D	D	SOIC	8	75	506.6	8	3940	4.32
SN65LVEL11D.B	D	SOIC	8	75	506.6	8	3940	4.32
SN65LVEL11DGK	DGK	VSSOP	8	80	330.2	6.6	3005	1.88
SN65LVEL11DGK.B	DGK	VSSOP	8	80	330.2	6.6	3005	1.88

PACKAGE OUTLINE

DGK0008A

VSSOP - 1.1 mm max height

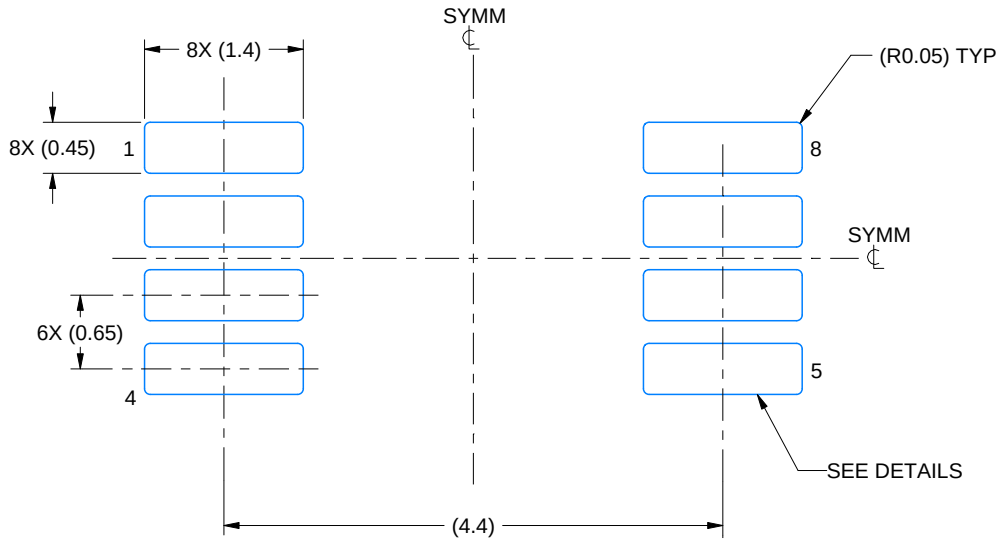
SMALL OUTLINE PACKAGE



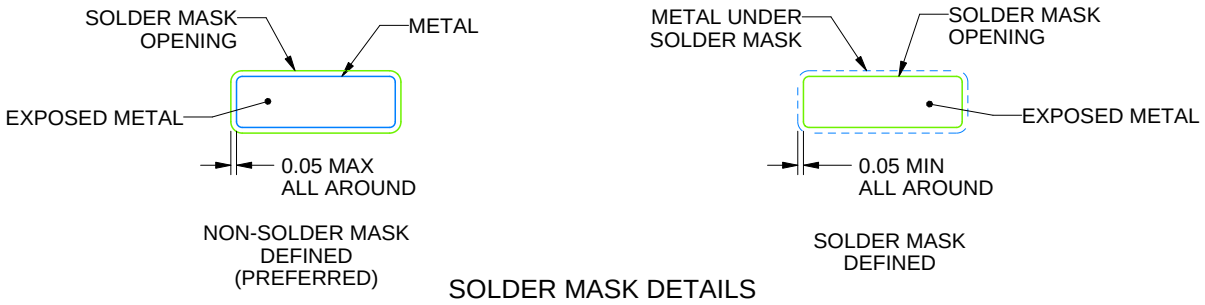
PowerPAD is a trademark of Texas Instruments.

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X

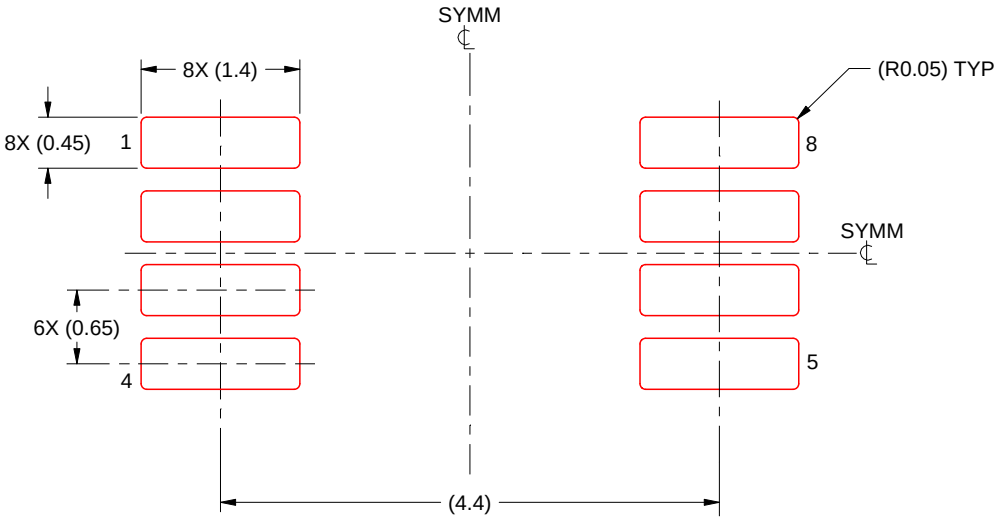


SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

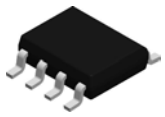


SOLDER PASTE EXAMPLE
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

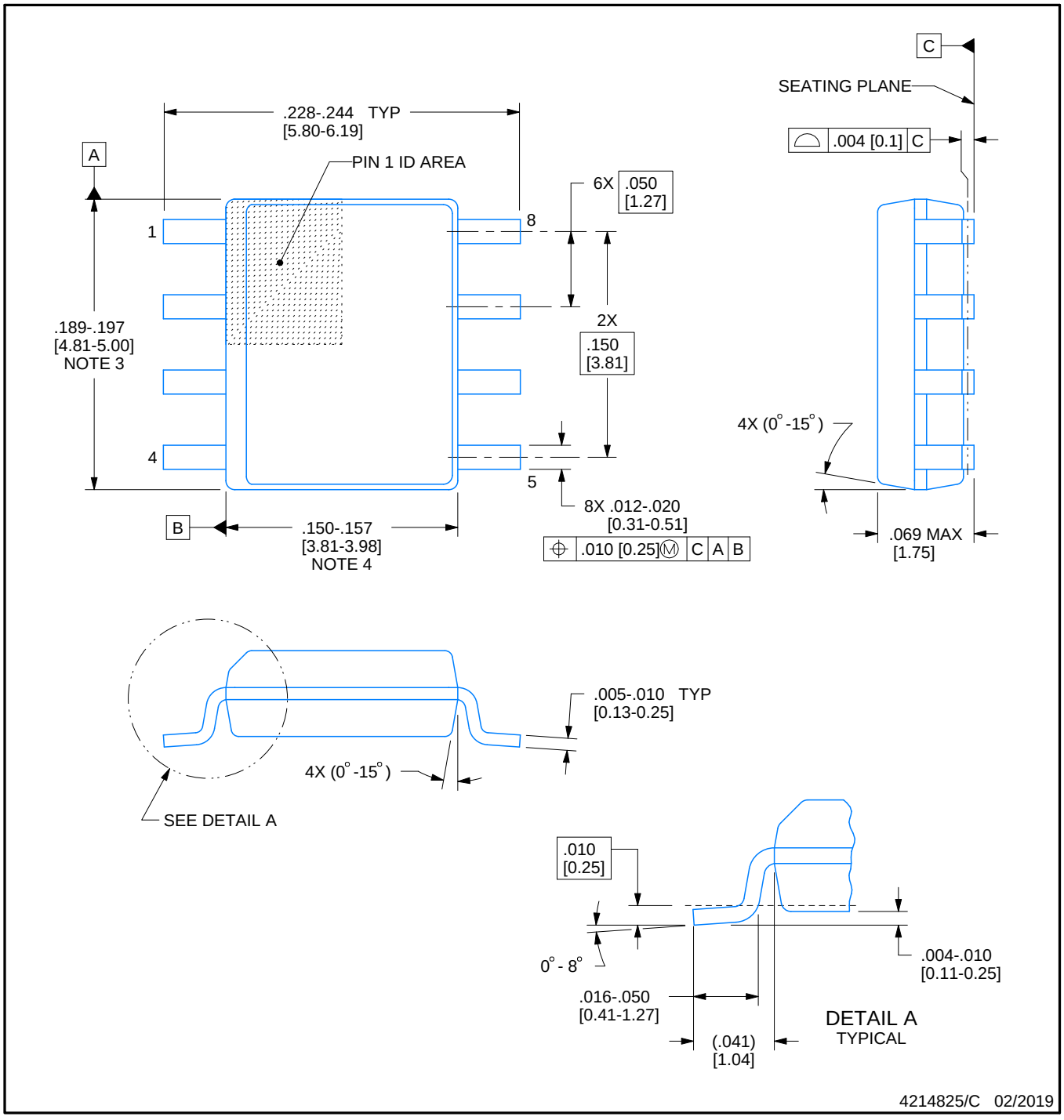


PACKAGE OUTLINE

D0008A

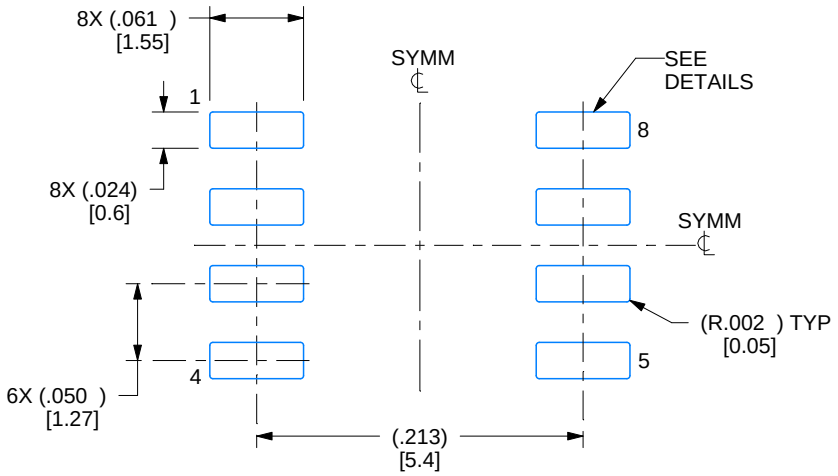
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

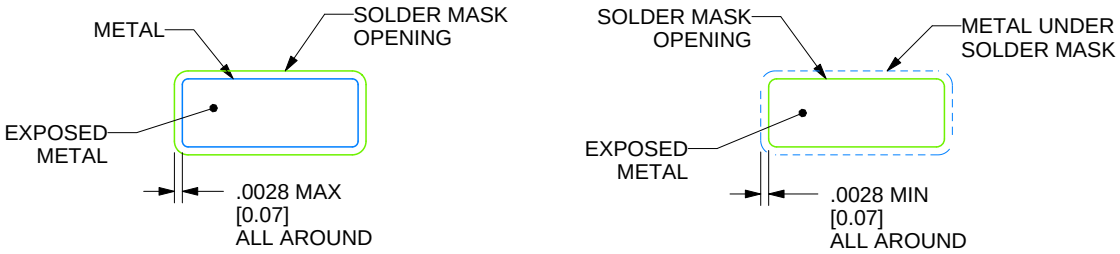


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

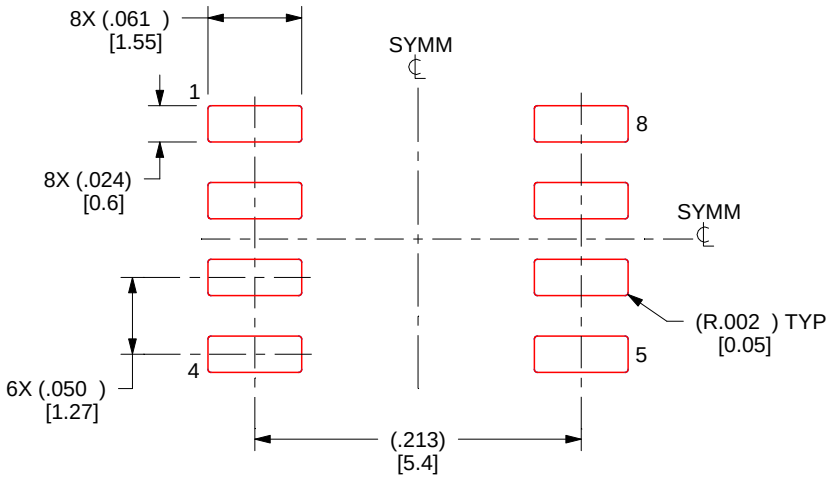
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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